

Bundesanstalt für Materialforschung und -prüfung (BAM)

in cooperation with the Committee of Chemists of the GDMB
Gesellschaft der Metallurgen und Bergleute e.V.

Certified Reference Material

BAM-M325

AlSi7MgSr

Certified Values

Element	Mass fraction ¹⁾ in %	Uncertainty ²⁾ in %
Si	6.83	0.14
Fe	0.143	0.005
Cu	0.0197	0.0006
Mn	0.0112	0.0002
Mg	0.504	0.009
Zn	0.0555	0.0008
Ti	0.117	0.004
	in mg/kg	in mg/kg
Cr	63.4	1.6
Ni	47.8	1.8
Ca	26	4
Cd	22.0	1.0
Ga	191	5
Li	8.3	1.5
Pb	104	7
Sb	37	4
Sn	183	5
Sr	301	13
V	95.7	1.2
Zr	56.9	1.6

¹⁾ Unweighted mean value of the means of accepted sets of data (consisting of at least 5 single results), each set being obtained by a different laboratory and/or a different method of measurement.

²⁾ Estimated expanded uncertainty U with a coverage factor of $k = 2$, corresponding to a level of confidence of approx. 95 %, as defined in the Guide to the Expression of Uncertainty in Measurement, (GUM, ISO/IEC Guide 98-3:2008).

This certificate is valid until there is a revocation from the producer of the material.

Informative Values

Element	Mass fraction ¹⁾ in mg/kg	Uncertainty ²⁾ in mg/kg
Na	13.5	2.8

¹⁾ Values were not certified, but given for information, when the number of accepted data sets was considered to be too low (< 5) or when the uncertainty from the inter-laboratory certification was considerably larger than the expected range or in case there were hints that the material was not homogeneous enough.

²⁾ Estimated expanded uncertainty U with a coverage factor of $k = 2$, corresponding to a level of confidence of approx. 95 %, as defined in the Guide to the expression of uncertainty in measurement, (GUM, ISO/IEC Guide 98-3:2008).

Sample Description

The Reference Material is available in the form of discs (approx. 50 mm diameter and 30 mm height).

Recommended Use

The CRM is intended for establishing or checking the calibration of spark optical emission spectrometers for the analysis of samples of similar matrix composition. The minimum sample size for wet chemical analysis is 0.2 g.

Instructions for Use

Before use, the surface of the material must be prepared by milling or turning on a lathe. For wet chemical analysis chips must be prepared by turning or milling of the sample surface.

Transport and Storage

The material should be stored in a dry and clean environment at room temperature. Transport can be done under normal ambient conditions.

Participating Laboratories

AMAG Austria Metall AG, Ranshofen, Austria

Bundesanstalt für Materialforschung und -prüfung (BAM), Berlin, Germany

Constellium, Centre de Recherches de Voreppe, Voreppe, France

Speira GmbH, R&D, Bonn, Germany

Leichtmetall Aluminium Giesserei Hannover GmbH, Hannover, Germany

Łukasiewicz Research Network – Institute of Non-Ferrous Metals, Gliwice, Poland

Novelis Koblenz GmbH, Koblenz, Germany

OTTO FUCHS KG, Meinerzhagen, Germany

revierlabor, Essen, Germany

Suisse Technology Partners, Neuhausen, Switzerland

Metrological Traceability

To ensure traceability of the certified mass fractions to the SI (Système International d'Unités) calibration was performed using standard solutions prepared from pure metals or stoichiometric compounds or with traceable commercial calibration solutions.

Means of Accepted Data Sets

Certified values
Mass fraction in %

Line No.	Si	Fe	Cu	Mn	Mg	Zn	Ti		Cr	Ni	Ca
1	6.66	0.138	0.0187	0.0109	0.482	0.0538	---		58.8	42.0	19.8
2	6.69	0.139	0.0190	0.0109	0.488	0.0542	---		59.7	45.3	23.3
3	6.74	0.139	0.0194	0.0109	0.490	0.0543	0.1108		59.9	46.1	26.9
4	6.76	0.140	0.0195	0.0110	0.492	0.0548	0.1128		60.7	47.1	27.2
5	6.77	0.140	0.0196	0.0110	0.498	0.0549	0.1132		61.5	47.1	27.7
6	6.83	0.140	0.0196	0.0111	0.507	0.0549	0.1154		63.0	48.0	30.2
7	6.83	0.141	0.0198	0.0112	0.507	0.0551	0.1157		63.1	48.1	
8	6.89	0.141	0.0198	0.0112	0.507	0.0551	0.1157		63.2	48.4	
9	6.99	0.142	0.0198	0.0113	0.511	0.0551	0.1175		63.5	48.7	
10	7.10	0.143	0.0202	0.0113	0.511	0.0552	0.1179		63.7	50.0	
11		0.146	0.0202	0.0113	0.514	0.0556	0.1184		64.5	50.2	
12		0.147	0.0207	0.0114	0.515	0.0557	0.1191		64.8	52.7	
13		0.151		0.0115	0.515	0.0564	0.1194		65.3		
14		0.152		0.0115	0.515	0.0565	0.1197		66.0		
15		0.153		0.0117	0.515	0.0577	0.1199		67.5		
16						0.0582	0.1200		68.7		
17							0.1210				
M	6.83	0.143	0.0197	0.0112	0.504	0.0555	0.1171		63.4	47.8	25.9
s_M	0.14	0.006	0.0006	0.0003	0.012	0.0012	0.0031		2.8	2.7	3.8
\bar{s}_i	0.07	0.003	0.0004	0.0003	0.007	0.0008	0.0016		1.3	1.6	2.3

Certified values
Mass fraction in mg/kg

Values for
information

Line No.	Cd	Ga	Li	Pb	Sb	Sn	Sr	V	Zr	Na
1	20.0	179.0	7.28	91.2	32.2	175.5	290.1	93.0	53.0	12.3
2	20.4	181.6	7.73	95.9	33.9	176.2	290.5	93.6	53.2	13.6
3	21.1	186.6	7.77	97.0	34.5	177.2	293.8	93.7	55.3	14.5
4	21.7	187.7	8.34	97.3	38.2	178.2	295.1	94.5	56.1	
5	21.9	188.0	8.36	97.4	38.4	178.4	299.1	94.8	56.5	
6	22.0	189.1	8.43	98.8	38.7	179.4	299.2	95.2	56.7	
7	22.1	189.1	8.46	106.3	40.2	179.5	304.0	95.8	57.2	
8	22.1	189.6	8.62	109.3	40.5	179.7	304.4	96.0	57.5	
9	22.5	191.0	8.97	111.8		183.1	304.9	96.3	57.6	
10	22.5	193.1	9.00	113.1		186.6	305.1	97.1	58.4	
11	22.6	194.0		113.5		188.3	305.5	97.2	60.6	
12	22.7	194.7		115.2		191.1	309.7	97.2	60.8	
13	23.0	196.8				191.8	311.4	97.5	---	
14	24.2	199.0				194.8	---	97.7	---	
15		201.9								
M	22.0	190.7	8.30	103.9	37.1	182.8	301.0	95.7	56.9	13.5
s_M	1.1	6.2	0.56	8.5	3.1	6.5	7.0	1.6	2.5	1.2
\bar{s}_i	0.6	2.7	0.26	3.0	2.1	5.9	6.1	1.0	1.9	0.8

The laboratory mean values have been examined statistically to eliminate outlying values. Where a " --- " appears in the table it indicates that an outlying value has been omitted. A data set consists of at least 4 but usually 6 single values of one laboratory.

M : mean of laboratory means

s_M : standard deviation of laboratory means

\bar{s}_i : averaged repeatability standard deviation (square root of the mean of laboratory variances)

Analytical Method used for Certification

Element	Line Number	Method
Si	1, 2, 3, 6, 7, 8, 9, 10	ICP-OES, dissolution with NaOH
	4	Spectrophotometry
	5	Gravimetry
Fe	1, 2, 3, 6, 7, 8, 9, 12, 14	ICP-OES, dissolution with NaOH
	4	ICP-MS, dissolution with acid
	5	Spectrophotometry
	10, 13, 15	ICP-OES, dissolution with acid
Cu	11	FAAS, dissolution with acid
	1, 7	ICP-OES, dissolution with acid
	2	FAAS, dissolution with acid
	3, 4, 5, 6, 8, 9, 11	ICP-OES, dissolution with NaOH
Mn	10, 12	ICP-MS, dissolution with acid
	1, 2, 3, 4, 8, 9, 10, 11	ICP-OES, dissolution with NaOH
	5	FAAS, dissolution with acid
	6, 14, 15	ICP-OES, dissolution with acid
	7, 13	ICP-MS, dissolution with acid
Mg	12	Spectrophotometry
	1, 5, 7, 8, 13	ICP-OES, dissolution with acid
	2, 6, 9, 10, 12, 14, 15	ICP-OES, dissolution with NaOH
	3	FAAS, dissolution with acid
Zn	4, 11	ICP-MS, dissolution with acid
	1, 2, 4, 7, 12, 13	ICP-OES, dissolution with acid
	3, 5, 6, 9, 10, 11, 16	ICP-OES, dissolution with NaOH
	8	ICP-MS, dissolution with acid
Ti	14, 15	FAAS, dissolution with acid
	3, 7, 8, 10, 12, 13, 14, 16	ICP-OES, dissolution with NaOH
	4, 5, 9, 11, 17	ICP-OES, dissolution with acid
	6	ICP-MS, dissolution with acid
Cr	15	Spectrophotometry
	1, 3, 5, 7, 11, 13	ICP-OES, dissolution with acid
	2, 6, 8, 9, 10, 14, 16	ICP-OES, dissolution with NaOH
	4	FAAS, dissolution with acid
Ni	12, 15	ICP-MS, dissolution with acid
	1, 2, 4, 11	ICP-OES, dissolution with acid
	3, 5, 6, 7, 8, 9, 12	ICP-OES, dissolution with NaOH
	10	ICP-MS, dissolution with acid
Ca	1, 2, 3, 5, 6	ICP-OES, dissolution with acid
	4	ICP-OES, dissolution with NaOH
Cd	1, 2, 5, 8, 10, 11, 14	ICP-OES, dissolution with acid
	3, 9, 13	ICP-MS, dissolution with acid
	4, 6, 7, 12	ICP-OES, dissolution with NaOH

Element	Line Number	Method
Ga	1, 4, 12 2, 3, 7, 13, 14 5, 6, 8, 9, 10, 11, 15	ICP-MS, dissolution with acid ICP-OES, dissolution with acid ICP-OES, dissolution with NaOH
Li	1, 2, 6, 7 3, 9 4, 8, 10 5	ICP-OES, dissolution with acid ICP-MS, dissolution with acid ICP-OES, dissolution with NaOH FAES, dissolution with acid
Pb	1, 3, 6, 9, 11 2, 4, 10, 12 5, 7, 8	ICP-OES, dissolution with acid ICP-OES, dissolution with NaOH ICP-MS, dissolution with acid
Sb	1, 3, 5 2, 4 6, 7 8	ICP-OES, dissolution with NaOH ICP-OES, dissolution with acid ICP-MS, dissolution with acid ETAAS, dissolution with acid
Sn	1, 3, 5, 7, 12 2, 4, 8, 9, 11, 13, 14 6, 10	ICP-OES, dissolution with acid ICP-OES, dissolution with NaOH ICP-MS, dissolution with acid
Sr	1, 2, 9, 11, 12 3, 4, 6, 7, 8, 10, 13 5	ICP-OES, dissolution with acid ICP-OES, dissolution with NaOH ICP-MS, dissolution with acid
V	1, 2, 6, 7, 8, 9, 13 3, 5, 10, 11, 12 4, 14	ICP-OES, dissolution with NaOH ICP-OES, dissolution with acid ICP-MS, dissolution with acid
Zr	1, 3, 4, 8, 10, 12, 13 2 5, 6, 9, 11 7	ICP-OES, dissolution with NaOH Spectrophotometry ICP-OES, dissolution with acid ICP-MS, dissolution with acid
Na	1, 2, 3	<i>ICP-OES, dissolution with acid</i>

Abbreviations:

ETAAS – Electrothermal atomic absorption spectrometry
 FAAS – Flame atomic absorption spectrometry
 FAES – Flame atomic emission spectrometry
 ICP-OES – Inductively coupled plasma - optical emission spectrometry
 ICP-MS – Mass spectrometry with inductively coupled plasma

Technical Report

A detailed technical report describing the analysis procedures and the treatment of the analytical data used to certify BAM-M325 is available on request or can be downloaded from BAM website (www.bam.de).

Accepted as BAM-CRM on 2023-10-31

Bundesanstalt für Materialforschung und -prüfung (BAM)

Dr. S. Richter
Committee for Certification

Dr. S. Recknagel
Project Coordinator

BAM holds an accreditation as a reference material producer according to ISO/IEC 17034. This accreditation is valid only for the scope as specified in the certificate D-RM-11075-01-00. DAkkS is a signatory of the multilateral agreement (MLA) between EA, ILAC and IAF for mutual acceptance.



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